# IN1104 LVDS 4 Port High Speed Repeater

FAIRCHILD

SEMICONDUCTOR®

# FIN1104 LVDS 4 Port High Speed Repeater

### **General Description**

This 4 port repeater is designed for high speed interconnects utilizing Low Voltage Differential Signaling (LVDS) technology. The FIN1104 accepts and outputs LVDS levels with a typical differential output swing of 330 mV which provides low EMI at ultra low power dissipation even at high frequencies. The FIN1104 provides a V<sub>BB</sub> reference for AC coupling on the inputs. In addition the FIN1104 can directly accept LVPECL, HSTL, and SSTL-2 for translation to LVDS.

### Features

- Greater than 800 Mbps data rate
- 3.3V power supply operation
- 3.5 ps maximum random jitter and 135 ps maximum deterministic jitter
- Wide rail-to-rail common mode range
- LVDS receiver inputs accept LVPECL, HSTL, and SSTL-2 directly
- Ultra low power consumption
- 20 ps typical channel-to-channel skew
- Power off protection
- > 7.5 kV HBM ESD Protection
- Meets or exceeds the TIA/EIA-644-A LVDS standard
- Available in space saving 24-Lead TSSOP package
- Open circuit fail safe protection
- V<sub>BB</sub> reference output

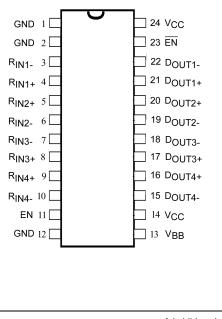
# **Ordering Code:**

Order Number	Package Number	Package Description
FIN1104MTC	MTC24	24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Devices also available	in Tape and Reel, Specify	by appending suffix letter "X" to the ordering code.

### **Pin Descriptions**

Pin Name	Description
R <sub>IN1+</sub> , R <sub>IN2+</sub> , R <sub>IN3+</sub> , R <sub>IN4+</sub>	Non-inverting LVDS Input
R <sub>IN1-</sub> , R <sub>IN2-</sub> , R <sub>IN3-</sub> , R <sub>IN4-</sub>	Inverting LVDS Input
$\begin{array}{c} D_{OUT1+},  D_{OUT2+}, \\ D_{OUT3+},  D_{OUT4+} \end{array}$	Non-inverting Driver Output
$\begin{array}{c} D_{OUT1-},D_{OUT2-},\\ D_{OUT3-},D_{OUT4-} \end{array}$	Inverting Driver Output
EN	Driver Enable Pin for All Output
EN	Inverting Driver Enable Pin for all Outputs
V <sub>CC</sub>	Power Supply
GND	Ground
V <sub>BB</sub>	Reference Voltage Output

### **Connection Diagram**



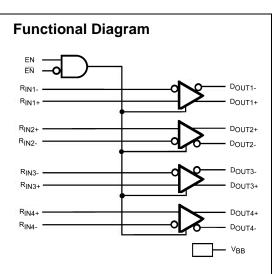
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### **Function Table**

Inputs Outputs EN EN  $\mathbf{D}_{\mathbf{IN}^+}$ D<sub>IN-</sub> D<sub>OUT+</sub> D<sub>OUT-</sub> Н L Н L Н L Н L L Н L Н Н L Fail Safe Case Н L Х н Х Х Ζ Ζ Х L Х Х Ζ Ζ

H = HIGH Logic Level L = LOW Logic Level X = Don't Care Z = High Impedance



# Absolute Maximum Ratings(Note 1)

Supply Voltage (V <sub>CC</sub> )	-0.5V to +4.6V
LVDS DC Input Voltage (VIN)	-0.5V to +4.6V
LVDS DC Output Voltage (V <sub>OUT</sub> )	-0.5V to +4.6V
Driver Short Circuit Current (I <sub>OSD</sub> )	Continuous 10 mA
Storage Temperature Range (T <sub>STG</sub> )	-65°C to +150°C
Max Junction Temperature (T <sub>J</sub> )	150°C
Lead Temperature (T <sub>L</sub> )	
(Soldering, 10 seconds)	260°C
ESD (Human Body Model)	7500V
ESD (Machine Model)	400V

# **Recommended Operating** Conditions

Supply Voltage (V <sub>CC</sub> )	3.0V to 3.6V
Magnitude of Differential	
Voltage ( V <sub>ID</sub>  )	100 mV to $V_{\mbox{\scriptsize CC}}$
Common Mode Voltage	
Range (V <sub>IC</sub> )	$(0V +  V_{ID} /2)$ to $(V_{CC} -  V_{ID} /2)$
Operating Temperature (T <sub>A</sub> )	-40°C to +85°C

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Note 1: The "Absolute Maximum Ratings": are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature and output/input loading variables. Fairchild does not recommend operation of circuits outside databook specification.

# **DC Electrical Characteristics**

Symbol	Parameter	Test Conditions		Min	Typ (Note 2)	Мах	Units
V <sub>TH</sub>	Differential Input Threshold HIGH	See Figure 1; $V_{IC}$ = +0.05V, +1.2V, or $V_{CC}$	- 0.05V			100	mV
V <sub>TL</sub>	Differential Input Threshold LOW	See Figure 1; $V_{IC}$ = +0.05V, +1.2V, or $V_{CC}$	-0.05V	-100			mV
V <sub>IH</sub>	Input HIGH Voltage (EN or EN)			2.0		V <sub>CC</sub>	V
VIL	Input LOW Voltage (EN or EN)			GND		0.8	V
V <sub>OD</sub>	Output Differential Voltage			250	330	450	mV
$\Delta V_{OD}$	V <sub>OD</sub> Magnitude Change from Differential LOW-to-HIGH	$R_L$ = 100 $\Omega_i$ Driver Enabled, See Figure 2				25	mV
V <sub>OS</sub>	Offset Voltage			1.125	1.23	1.375	V
$\Delta V_{OS}$	Offset Magnitude Change from Differential LOW-to-HIGH					25	mV
I <sub>OS</sub> Short Circuit Output Current	Short Circuit Output Current	D <sub>OUT+</sub> = 0V and D <sub>OUT-</sub> = 0V, Driver Enabled			-3.4	-6	mA
		V <sub>OD</sub> = 0V, Driver Enabled			±3.4	±6	mA
I <sub>IN</sub>	Input Current (EN, EN, D <sub>INx+</sub> , D <sub>INx-</sub> )	$V_{IN} = 0V$ to $V_{CC}$ , Other Input = $V_{CC}$ or $0V$ (for Differential Inputs)				±20	μA
I <sub>OFF</sub>	Power Off Input or Output Current	$V_{CC} = 0V$ , $V_{IN}$ or $V_{OUT} = 0V$ to 3.6V				±20	μΑ
I <sub>CCZ</sub>	Disabled Power Supply Current	Drivers Disabled			5.4	11	mA
ICC	Power Supply Current	Drivers Enabled, Any Valid Input Condition			30.4	41	mA
I <sub>OZ</sub>	Disabled Output Leakage Current	Driver Disabled, $D_{OUT+} = 0V$ to 3.6V or $D_{OUT-} = 0V$ to 3.6V				±20	μA
VIC	Common Mode Voltage Range	$ V_{ID}  = 100 \text{ mV to } V_{CC}$	0	$V +  V_{ID} /2$		$V_{CC} - ( V_{ID} /2)$	V
CIN	Input Capacitance	Enat	ole Input		2.6		pF
		LVD	S Input		2.1		р
C <sub>OUT</sub>	Output Capacitance				2.8		pF
V <sub>BB</sub>	Output Reference Voltage	$V_{CC} = 3.3V$ , $I_{BB} = 0$ to $-275 \ \mu A$		1.125	1.2	1.375	V

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### **AC Electrical Characteristics**

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 3)	Max	Units
t <sub>PLHD</sub>	Differential Output Propagation Delay		0.75	1.1	1.75	ns
	LOW-to-HIGH					
t <sub>PHLD</sub>	Differential Output Propagation Delay		0.75	1.1	1.75	ns
	HIGH-to-LOW	$R_L = 100 \ \Omega$ , $C_L = 5 \ pF$ ,				
t <sub>TLHD</sub>	Differential Output Rise Time (20% to 80%)	$V_{ID} = 200 \text{ mV}$ to 450 mV,	0.29	0.4	0.58	ns
t <sub>THLD</sub>	Differential Output Fall Time (80% to 20%)	$V_{IC} =  V_{ID} /2$ to $V_{CC} - ( V_{ID} /2)$ ,	0.29	0.4	0.58	ns
t <sub>SK(P)</sub>	Pulse Skew  t <sub>PLH</sub> - t <sub>PHL</sub>	Duty Cycle = 50%,		0.02	0.2	ns
t <sub>SK(LH)</sub> ,	Channel-to-Channel Skew	See Figure 1 and Figure 3		0.02	0.15	ns
t <sub>SK(HL)</sub>	(Note 4)			0.02	0.15	
t <sub>SK(PP)</sub>	Part-to-Part Skew (Note 5)				0.5	ns
f <sub>MAX</sub>	Maximum Frequency (Note 6)(Note 7)	1	400	800		MHz
t <sub>PZHD</sub>	Differential Output Enable Time	$R_L = 100 \ \Omega, \ C_L = 5 \ \text{pF},$ See Figure 2 and Figure 3		2.2	5	
	from Z to HIGH			2.2	5	ns
t <sub>PZLD</sub>	Differential Output Enable Time			2.5	5	ns
	from Z to LOW					
t <sub>PHZD</sub>	Differential Output Disable Time			1.8	5	ns
	from HIGH to Z			1.0	5	115
t <sub>PLZD</sub>	Differential Output Disable Time			2.1	5	ns
	from LOW to Z			2.1	5	115
t <sub>DJ</sub>	LVDS Data Jitter,	$V_{ID} = 300 \text{ mV}, \text{ PRBS} = 2^{23} \text{ - } 1,$ $V_{IC} = 1.2 \text{V} \text{ at } 800 \text{ Mbps}$		85	135	ps
	Deterministic			05	155	ps
t <sub>RJ</sub>	LVDS Clock Jitter,	V <sub>ID</sub> = 300 mV,	0.4	2.1	3.5	ps
	Random (RMS)	V <sub>IC</sub> = 1.2V at 400 MHz		2.1		

Note 4: t<sub>SK(LH)</sub>, t<sub>SK(HL)</sub> is the skew between specified outputs of a single device when the outputs have identical loads and are switching in the same direction.

Note 5:  $t_{SK(PP)}$  is the magnitude of the difference in propagation delay times between any specified terminals of two devices switching in the same direction (either Low-to-HIGH or HIGH-to-LOW) when both devices operate with the same supply voltage, same temperature, and have identical test circuits. Note 6: Passing criteria for maximum frequency is the output  $V_{OD} > 200$  mV and the duty cycle is 45% to 55% with all channels switching.

Note 7: Output loading is transmission line environment only;  $C_L$  is < 1 pF of stray test fixture capacitance.

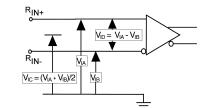
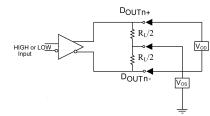
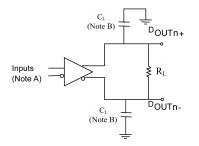


FIGURE 1. Differential Receiver Voltage Definitions and Propagation and Transition Time Test Circuit



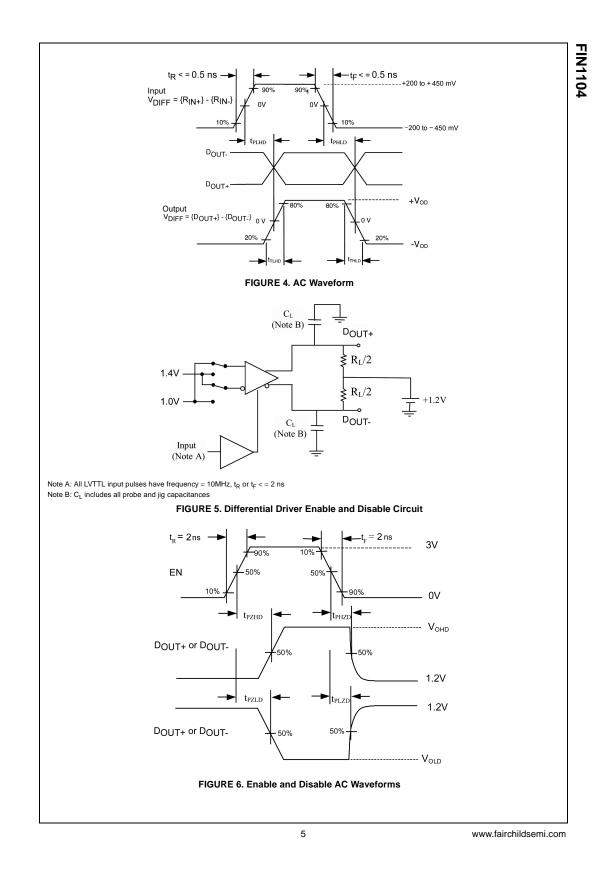


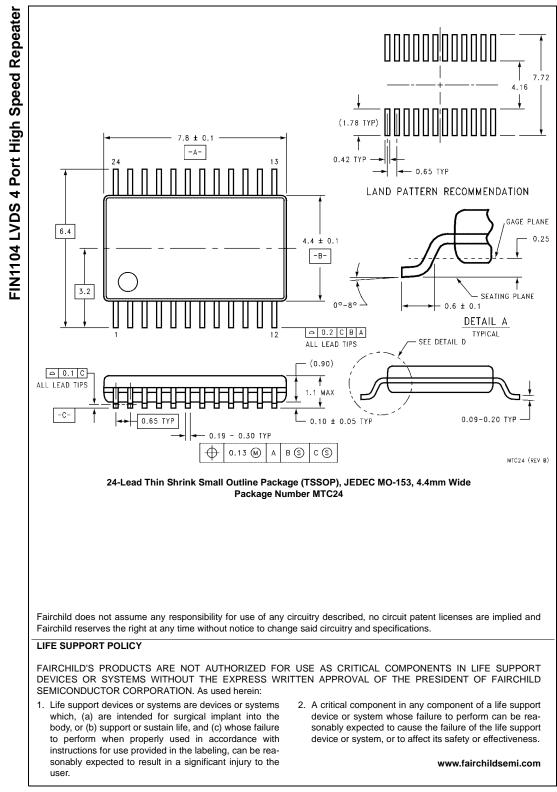


Note A: All LVDS input pulses have frequency = 10 MHz,  $t_R$  or  $t_F <$  = 0.5 ns

Note B:  $\mathbf{C}_{\mathsf{L}}$  includes all probe and test fixture capacitances

FIGURE 3. Differential Driver Propagation Delay and Transition Time Test Circuit





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